

LOW NOISE 150mA LDO REGULATOR

NO.EA-059-130409

OUTLINE

The R1112N Series are CMOS-based voltage regulator ICs with high output voltage accuracy, extremely low supply current, low ON-resistance, and high Ripple Rejection. Each of these voltage regulator ICs consists of a voltage reference unit, an error amplifier, resistors, a current limit circuit, and a chip enable circuit.

These ICs perform with low dropout voltage and a chip enable function. The line transient response and load transient response of the R1112N Series are excellent, thus these ICs are very suitable for the power supply for hand-held communication equipment.

The output voltage of these ICs is fixed with high accuracy. Since the package for these ICs is SOT-23-5 (Mini-mold) package, high density mounting of the ICs on boards is possible.

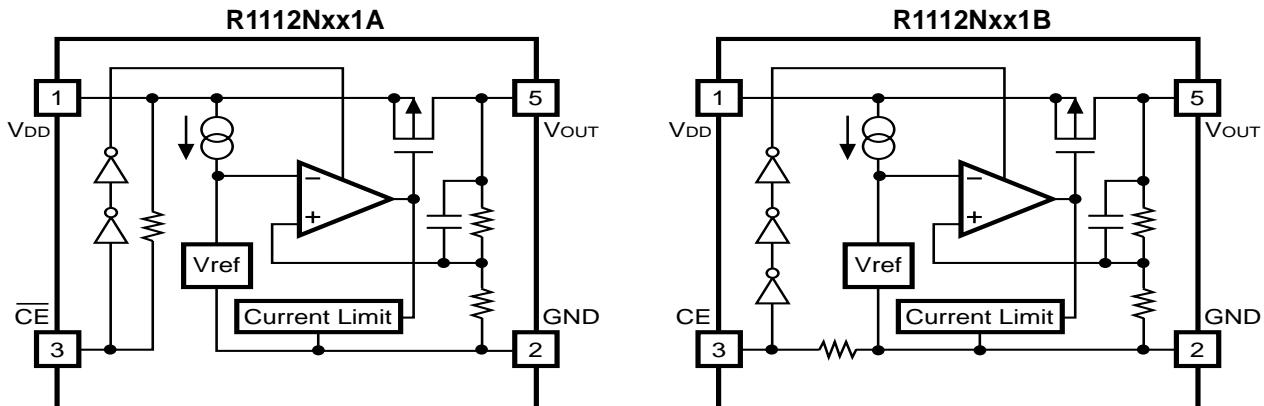
FEATURES

- Supply Current Typ. 100 μ A
- Standby Current Typ. 0.1 μ A
- Dropout Voltage Typ. 0.19V ($I_{out}=100mA$ 3.0V Output type)
- Ripple Rejection Typ. 80dB(f=1kHz)
- Temperature-Drift Coefficient of Output Voltage Typ. $\pm 100ppm/^\circ C$
- Line Regulation Typ. 0.05%/V
- Output Voltage Accuracy $\pm 2.0\%$
- Excellent Dynamic Response
- Package SOT-23-5(Mini-mold)
- Output Voltage 1.5V to 5.0V (0.1V steps)
(For other voltages, please refer to MARK INFORMATIONS.)
- Built-in chip enable circuit (2 types; A: active "Low", B: active "High")
- Pin-out Similar to the LP2980/LP2985
- Built-in fold-back protection circuit Typ.30mA (Current at short mode)
- Ceramic capacitors recommended to be used with this IC

APPLICATIONS

- Power source for cellular phones such as GSM, CDMA and various kinds of PCSs.
- Power source for electrical appliances such as cameras, VCRs and camcorders.
- Power source for battery-powered equipment.

BLOCK DIAGRAM



SELECTION GUIDE

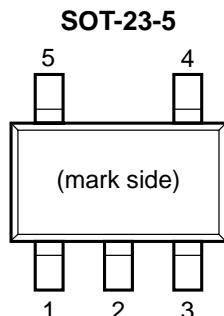
The output voltage, the active type for the ICs can be selected at the user's request.

Product Name	Package	Quantity per Reel	Pb Free	Halogen Free
R1112Nxx1*-TR-FE	SOT-23-5	3,000 pcs	Yes	Yes

xx: The output voltage can be designated in the range from 1.5V(15) to 5.0V(50) in 0.1V steps.
(For other voltages, please refer to MARK INFORMATIONS.)

* : Designation of Active Type.
(A) "L" active type
(B) "H" active type

PIN CONFIGURATION



PIN DESCRIPTION

Pin No	Symbol	Pin Description
1	V _{DD}	Input Pin
2	GND	Ground Pin
3	CE or CE	Chip Enable Pin
4	NC	No Connection
5	V _{OUT}	Output pin

ABSOLUTE MAXIMUM RATINGS

Symbol	Item	Rating	Unit
V _{IN}	Input Voltage	7.0	V
V _{CE}	Input Voltage(CE or CE Pin)	-0.3 to V _{IN} +0.3	V
V _{OUT}	Output Voltage	-0.3 to V _{IN} +0.3	V
I _{OUT}	Output Current	200	mA
P _D	Power Dissipation	250	mW
T _{opt}	Operating Temperature Range	-40 to 85	°C
T _{stg}	Storage Temperature Range	-55 to 125	°C

*) For Power Dissipation, please refer to PACKAGE INFORMATION.

ABSOLUTE MAXIMUM RATINGS

Electronic and mechanical stress momentarily exceeded absolute maximum ratings may cause the permanent damages and may degrade the life time and safety for both device and system using the device in the field.

The functional operation at or over these absolute maximum ratings is not assured.

ELECTRICAL CHARACTERISTICS

- R1112Nxx1A

Topt=25°C

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
VOUT	Output Voltage	VIN = Set VOUT + 1V 1mA ≤ IOUT ≤ 30mA	VOUT ×0.98		VOUT ×1.02	V
IOUT	Output Current	VIN = Set VOUT = 1.0V	150			mA
ΔVOUT/ΔIOUT	Load Regulation	VIN = Set VOUT + 1V 1mA ≤ IOUT ≤ 80mA		12	40	mV
VDIF	Dropout Voltage	Refer to the ELECTRICAL CHARACTERISTICS by OUTPUT VOLTAGE				
ISS	Supply Current	VIN = Set VOUT + 1V		100	170	μA
Istandby	Supply Current (Standby)	VIN = VCE = Set VOUT + 1V		0.1	1.0	μA
ΔVOUT/ΔVIN	Line Regulation	Set VOUT+0.5V ≤ VIN ≤ 6.0V IOUT = 30mA		0.05	0.20	%/V
RR	Ripple Rejection	f = 1kHz, Ripple 0.5Vp-p VIN = Set VOUT + 1V		80		dB
VIN	Input Voltage				6.0	V
ΔVOUT/ ΔT _{opt}	Output Voltage Temperature Coefficient	IOUT = 30mA -40°C ≤ Topt ≤ 85°C		±100		ppm/°C
ISC	Short Current Limit	VOUT = 0V		30		mA
RPU	CE Pull-up Resistance		2.5	5.0	10.0	MΩ
VCEH	CE Input Voltage "H"		1.5		VIN	V
VCEL	CE Input Voltage "L"		0		0.25	V
en	Output Noise	BW=10Hz to 100kHz		30		μVrms

RECOMMENDED OPERATING CONDITIONS (ELECTRICAL CHARACTERISTICS)

All of electronic equipment should be designed that the mounted semiconductor devices operate within the recommended operating conditions. The semiconductor devices cannot operate normally over the recommended operating conditions, even if when they are used over such conditions by momentary electronic noise or surge. And the semiconductor devices may receive serious damage when they continue to operate over the recommended operating conditions.

● R1112Nxx1B

Topt=25°C

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
VOUT	Output Voltage	VIN = Set VOUT + 1V 1mA ≤ IOUT ≤ 30mA	VOUT ×0.98		VOUT ×1.02	V
IOUT	Output Current	VIN = Set VOUT = 1.0V	150			mA
ΔVout/ΔIout	Load Regulation	VIN = Set VOUT + 1V 1mA ≤ IOUT ≤ 80mA		12	40	mV
V _{DIF}	Dropout Voltage	Refer to the ELECTRICAL CHARACTERISTICS by OUTPUT VOLTAGE				
I _{SS}	Supply Current	VIN = Set VOUT + 1V		100	170	μA
I _{standby}	Supply Current (Standby)	VIN = Set VOUT + 1V V _{CE} = GND		0.1	1.0	μA
ΔVout/ΔVIN	Line Regulation	Set VOUT + 0.5V ≤ VIN ≤ 6.0V IOUT = 30mA		0.05	0.20	%/V
RR	Ripple Rejection	f = 1kHz, Ripple 0.5Vp-p VIN = Set VOUT + 1V		80		dB
V _{IN}	Input Voltage				6.0	V
ΔVout/ΔT	Output Voltage Temperature Coefficient	IOUT = 30mA -40°C ≤ Topt ≤ 85°C		±100		ppm/°C
I _{SC}	Short Current Limit	VOUT = 0V	30			mA
R _{PD}	CE Pull-down Resistance		2.5	5.0	10.0	MΩ
V _{CEH}	CE Input Voltage "H"		1.5		V _{IN}	V
V _{CEL}	CE Input Voltage "L"		0		0.25	V
e _n	Output Noise	BW=10Hz to 100kHz		30		μVrms

RECOMMENDED OPERATING CONDITIONS (ELECTRICAL CHARACTERISTICS)

All of electronic equipment should be designed that the mounted semiconductor devices operate within the recommended operating conditions. The semiconductor devices cannot operate normally over the recommended operating conditions, even if when they are used over such conditions by momentary electronic noise or surge. And the semiconductor devices may receive serious damage when they continue to operate over the recommended operating conditions.

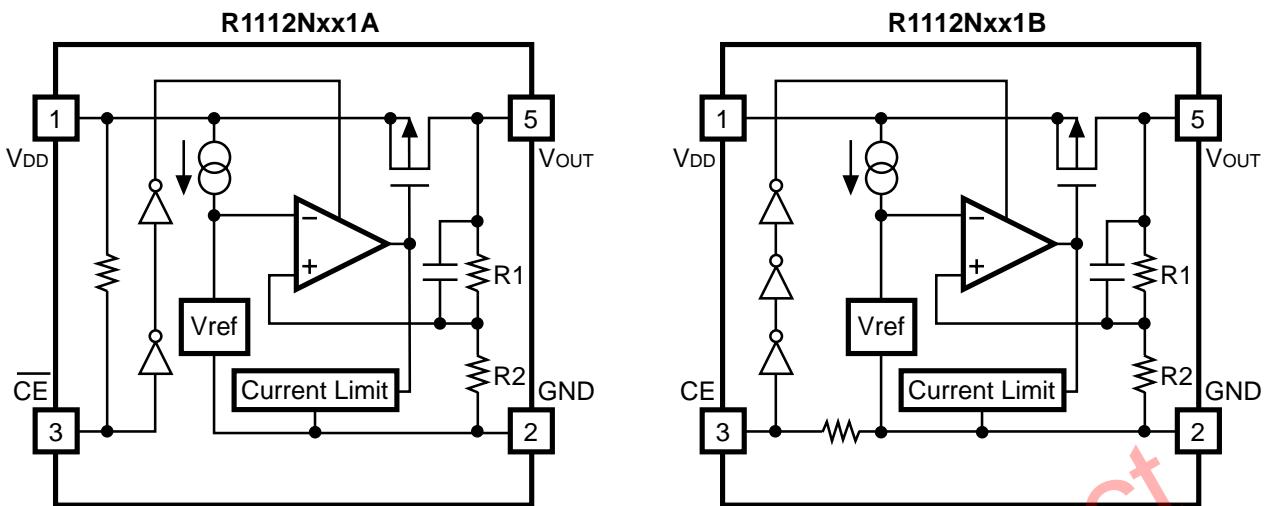
ELECTRICAL CHARACTERISTICS by OUTPUT VOLTAGE

Topt = 25°C

Output Voltage V _{OUT} (V)	Dropout Voltage		
	V _{DIF} (V)		
	Condition	Typ.	Max.
1.5 ≤ V _{OUT} ≤ 1.6	I _{OUT} = 100mA	0.32	0.55
1.7 ≤ V _{OUT} ≤ 1.8		0.28	0.47
1.9 ≤ V _{OUT} ≤ 2.3		0.25	0.35
2.4 ≤ V _{OUT} ≤ 2.7		0.20	0.29
2.8 ≤ V _{OUT} ≤ 5.0		0.19	0.26

*) The products of the Set Vout ≤ 1.8V, the operation may become unstable in case of V_{IN} ≤ 2.0V, so please use the products on condition that V_{IN} ≥ 2.0V.

OPERATION



In these ICs, fluctuation of the output voltage, V_{OUT} is detected by feed-back registers R_1 , R_2 , and the result is compared with a reference voltage by the error amplifier, so that a constant voltage is output. A current limit circuit for protection in short mode and a chip enable circuit, are included.

TECHNICAL NOTES

When using these ICs, consider the following points:

Phase Compensation

In these ICs, phase compensation is made for securing stable operation even if the load current is varied. For this purpose, be sure to use a capacitor C_{OUT} with good frequency characteristics and ESR (Equivalent Series Resistance).

We use Ceramic Capacitors for evaluation of these ICs.

Recommended Capacitors; GRM40X5R225K6.3 (Murata)

GRM40-034X5R335K6.3 (Murata)

GRM40-034X5R475K6.3 (Murata)

(Note: When the additional ceramic capacitors are connected to the Output Pin with Output capacitor for phase compensation, the operation might be unstable. Because of this, test these ICs with as same external components as ones to be used on the PCB.)

PCB Layout

Make V_{DD} and GND lines sufficient. If their impedance is high, picking up the noise or unstable operation may result. Connect a capacitor with a capacitance value of $2.2\mu F$ or more between V_{DD} and GND pin as close as possible.

Set external components, especially output capacitor as close as possible to the ICs and make wiring as short as possible.

TEST CIRCUITS

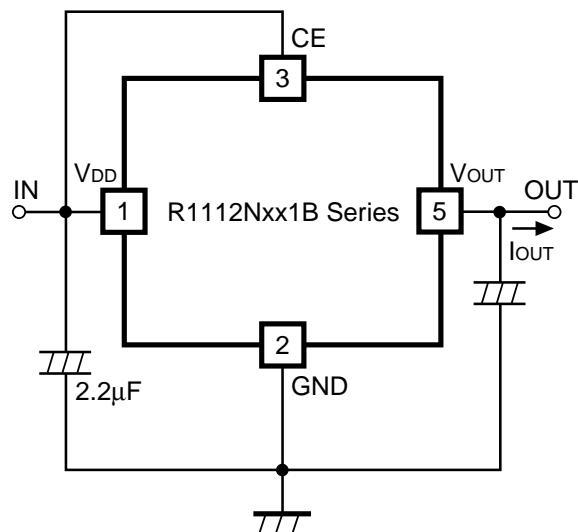


Fig.1 Standard test Circuit

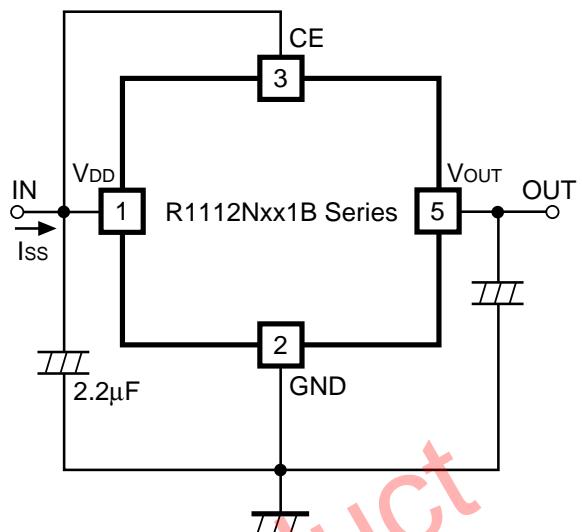


Fig.2 Supply Current Test Circuit

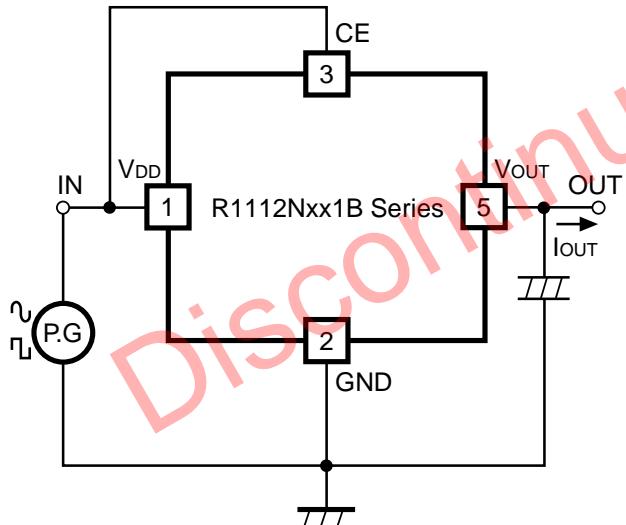


Fig.3 Ripple Rejection, Line Transient Response Test Circuit

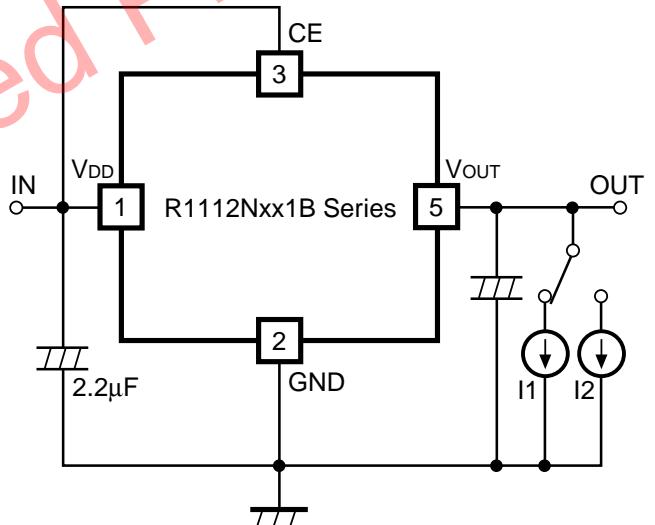
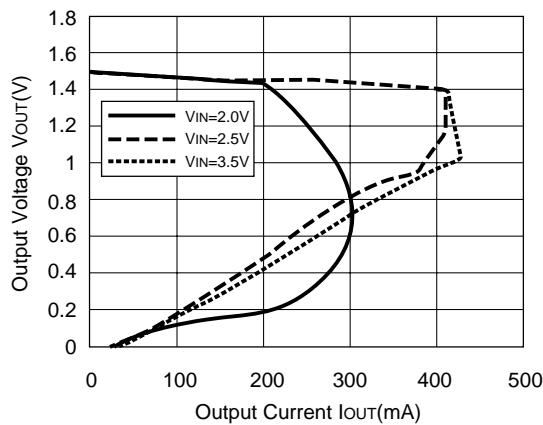
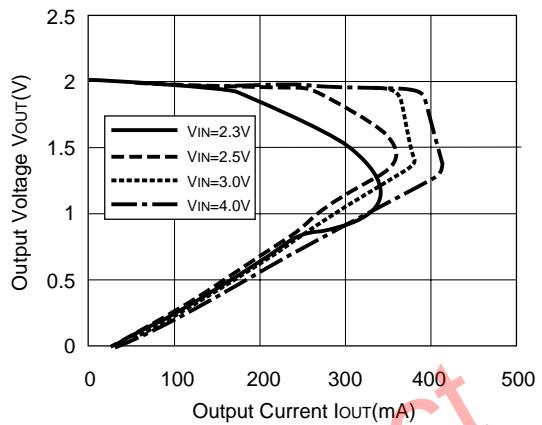
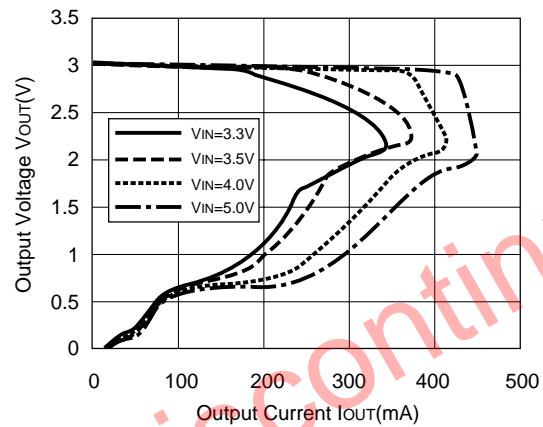
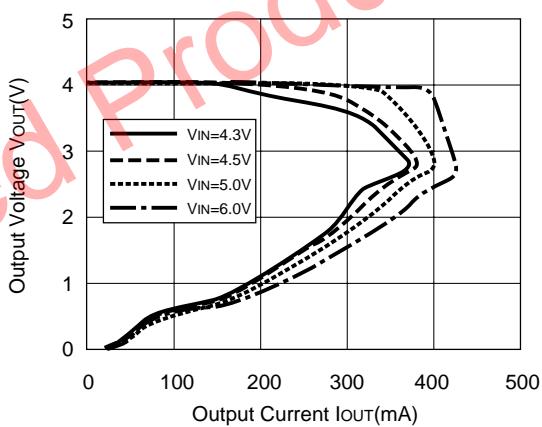
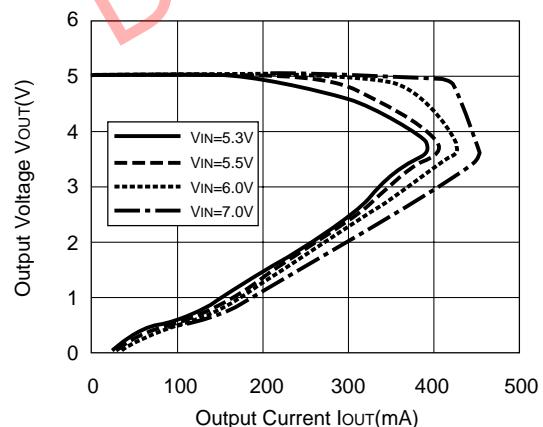


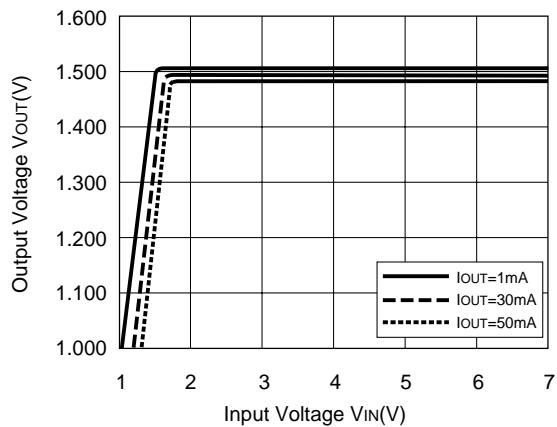
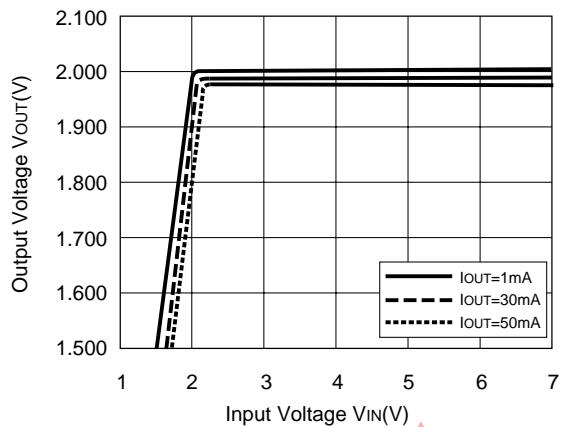
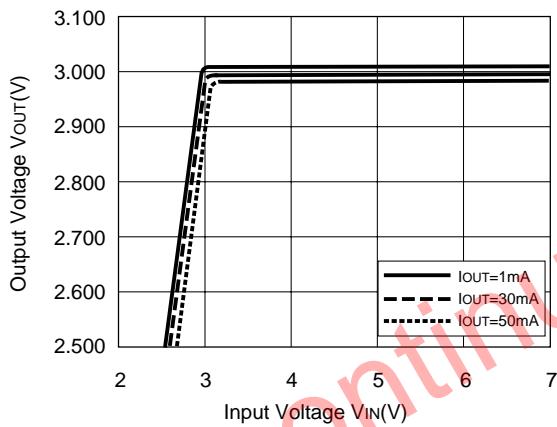
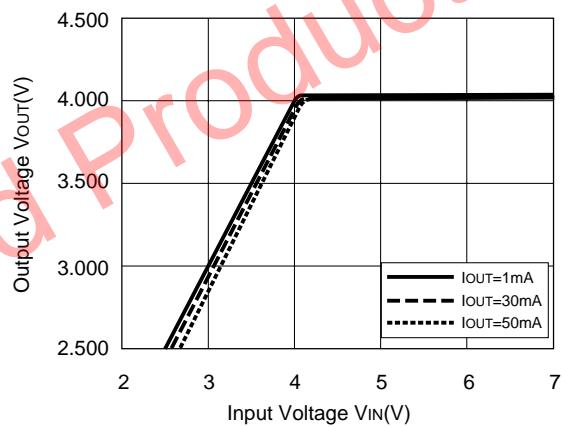
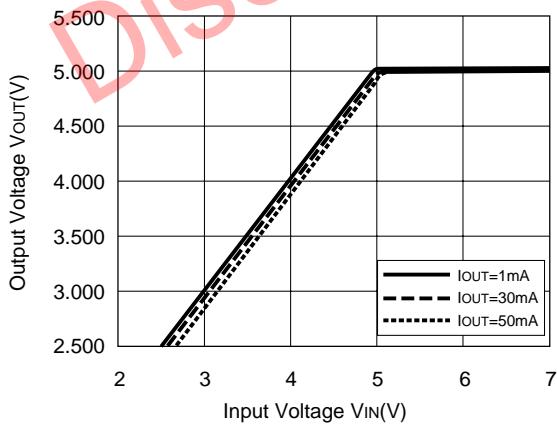
Fig.4 Load Transient Response Test Circuit

TYPICAL CHARACTERISTICS

1) Output Voltage vs. Output Current

R1112N151B**R1112N201B****R1112N301B****R1112N401B****R1112N501B**

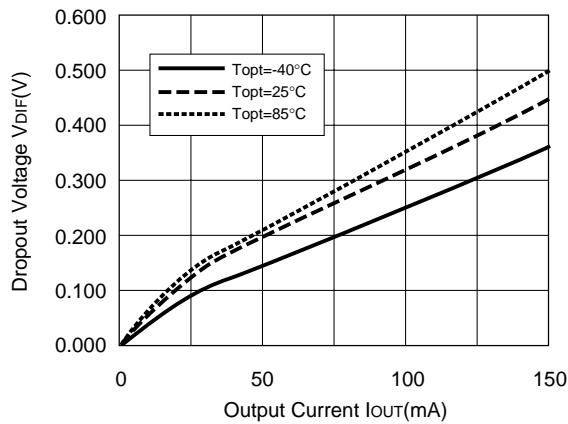
2) Output Voltage vs. Input Voltage

R1112N151B**R1112N201B****R1112N301B****R1112N401B****R1112N501B**

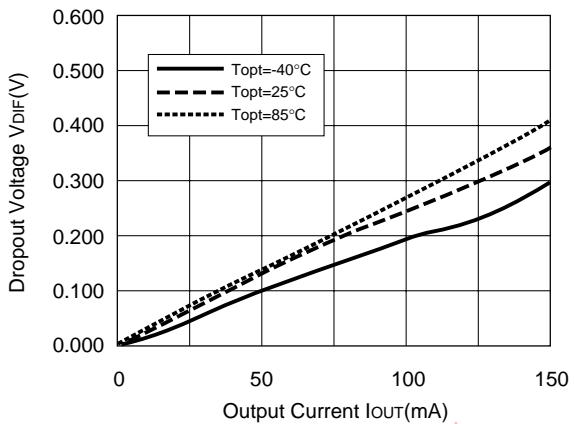
R1112N

3) Dropout Voltage vs. Output Current

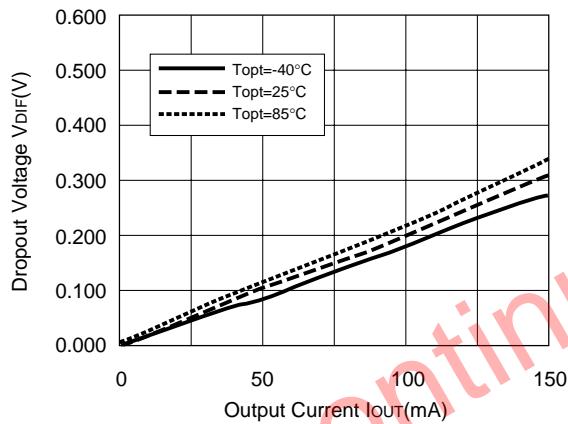
R1112N151B



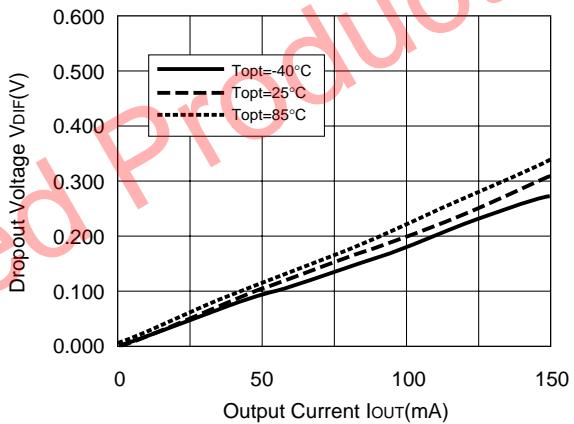
R1112N201B



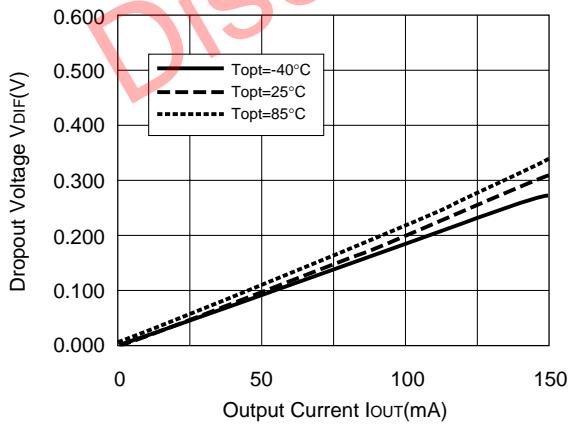
R1112N301B



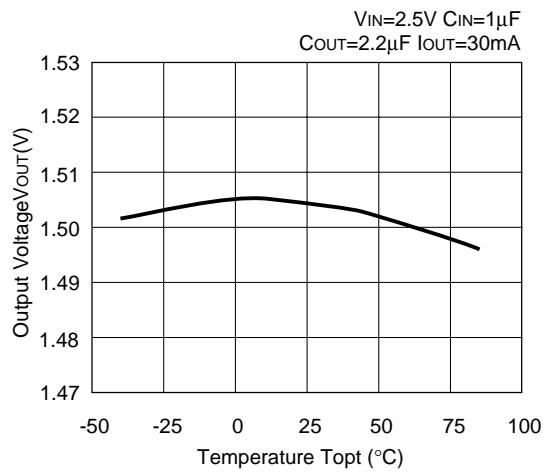
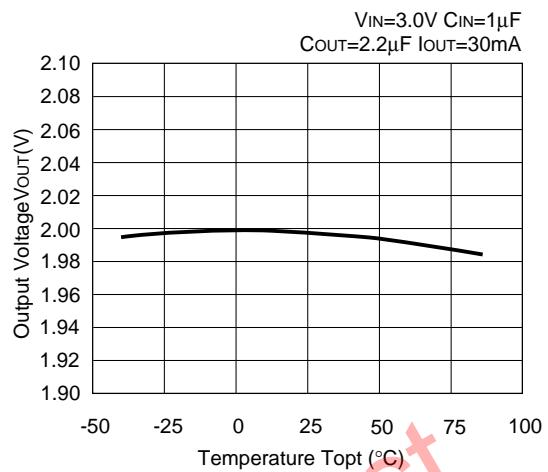
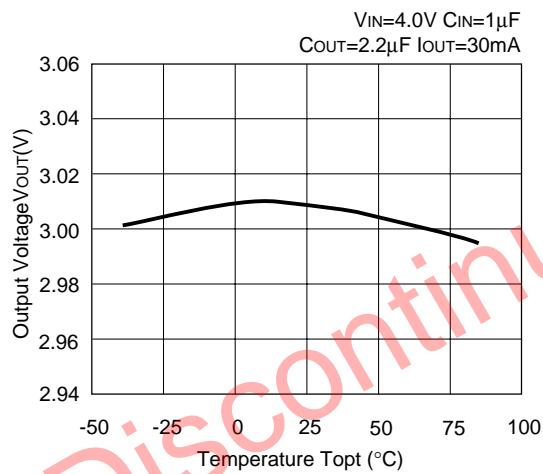
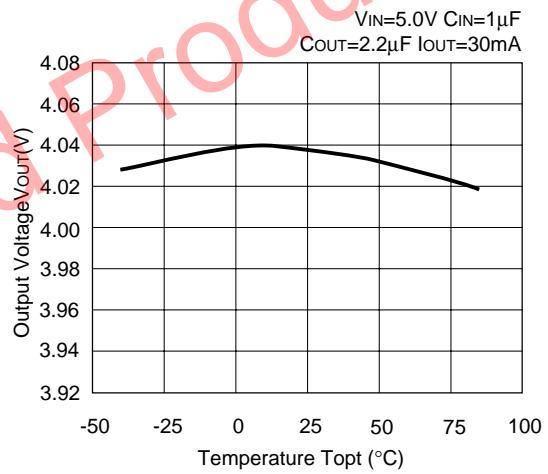
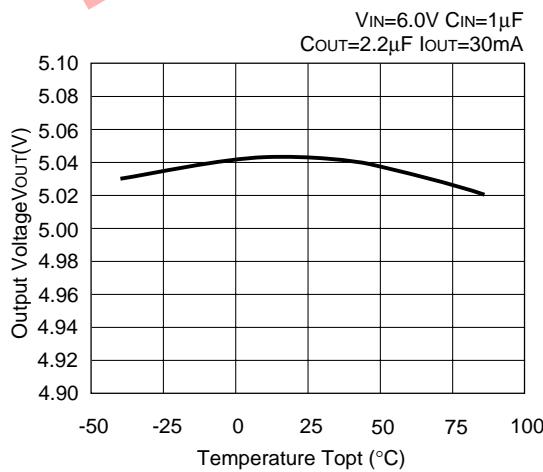
R1112N401B



R1112N501B



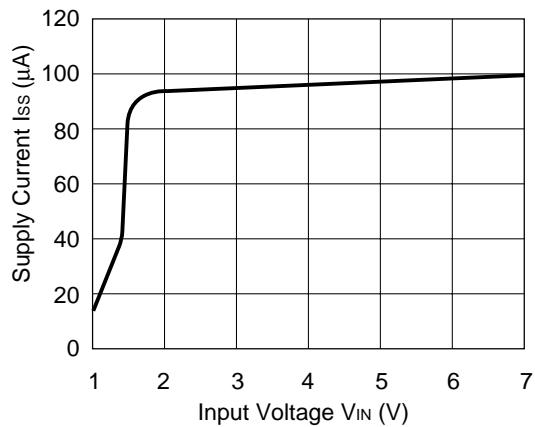
4) Output Voltage vs. Temperature

R1112N151A/B**R1112N201A/B****R1112N301A/B****R1112N401A/B****R1112N501A/B**

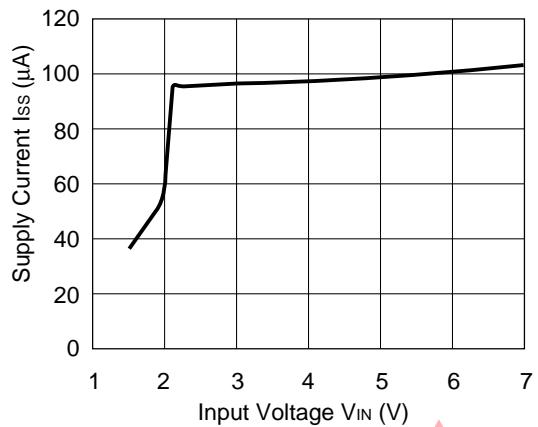
R1112N

5) Supply Current vs. Input Voltage

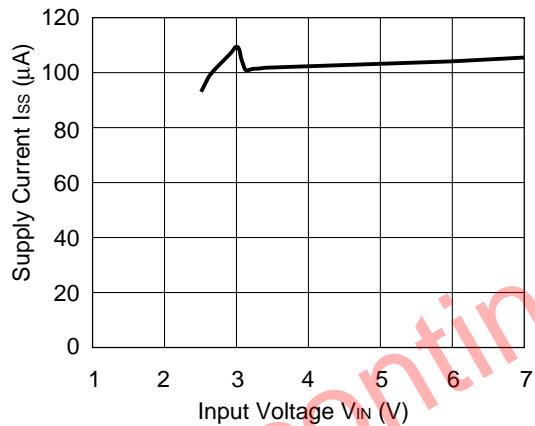
R1112N151B



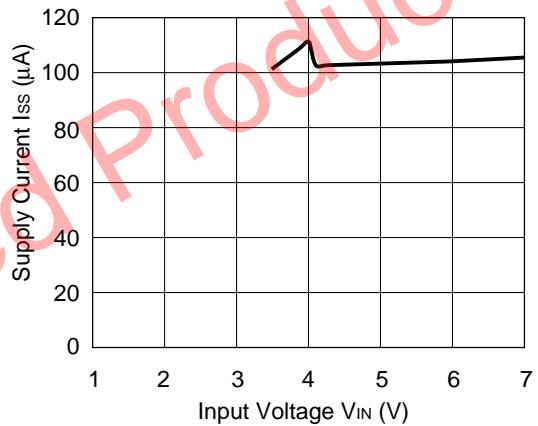
R1112N201B



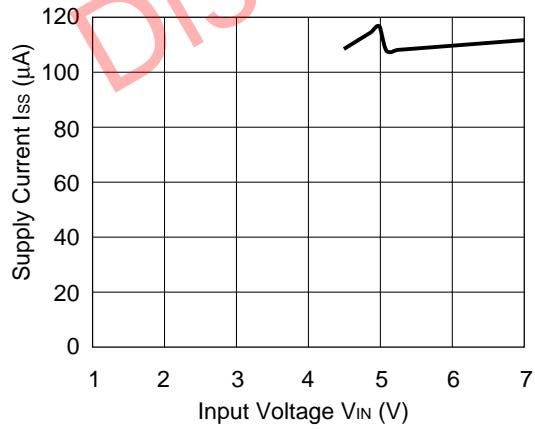
R1112N301B



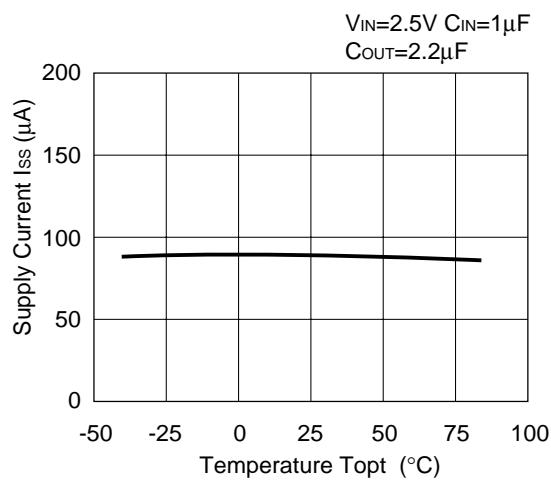
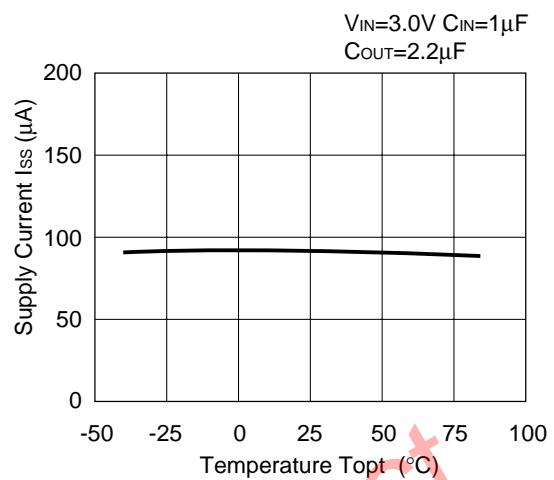
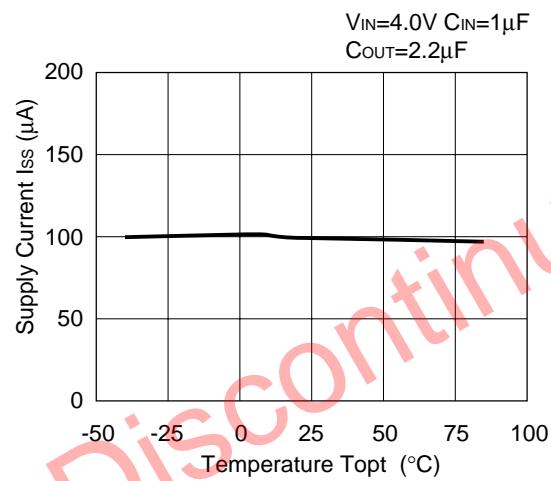
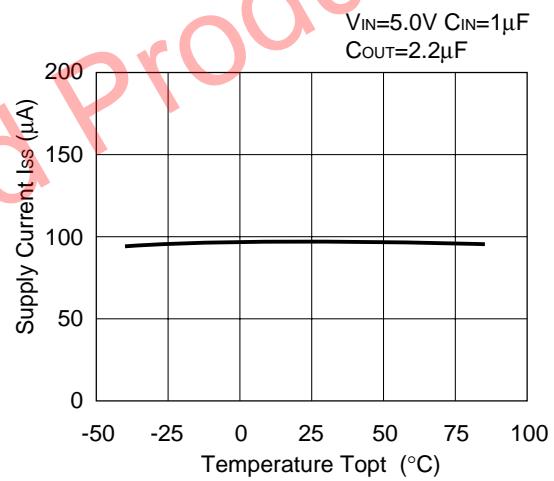
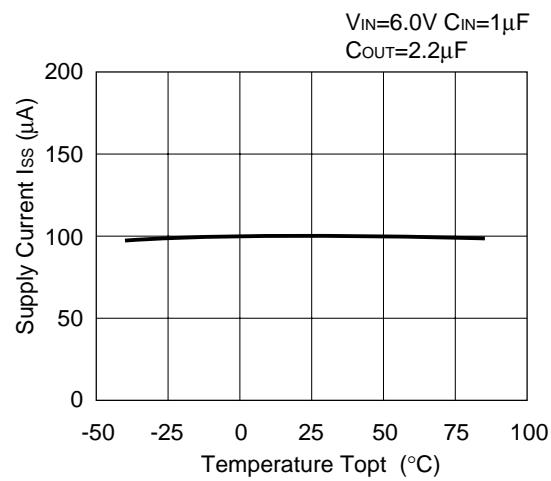
R1112N401B

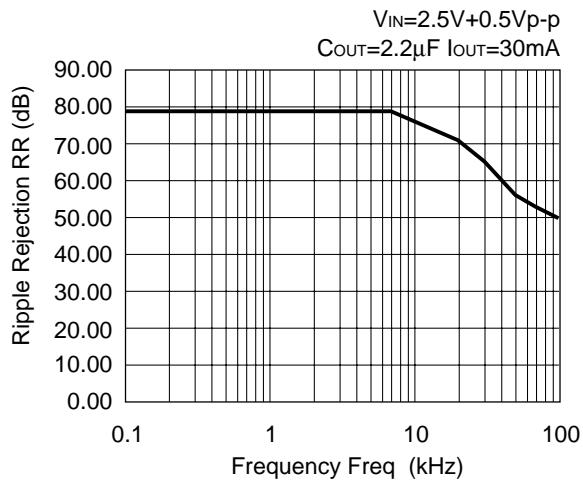
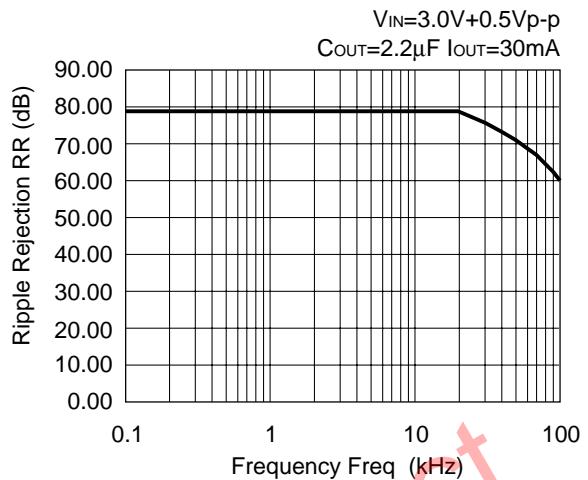
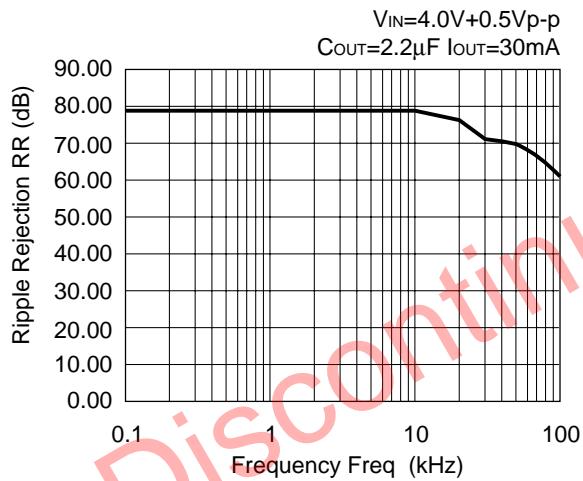
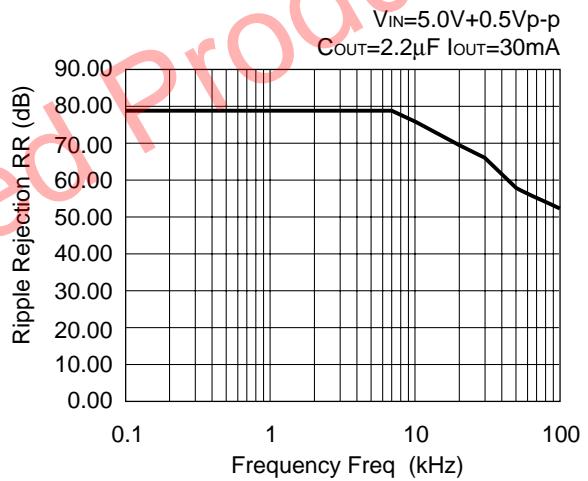
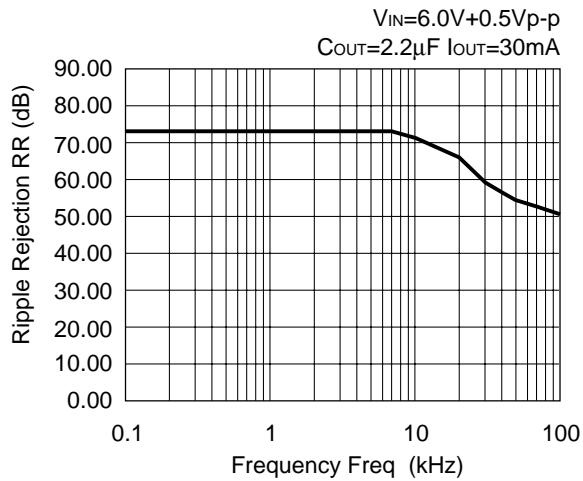


R1112N501B



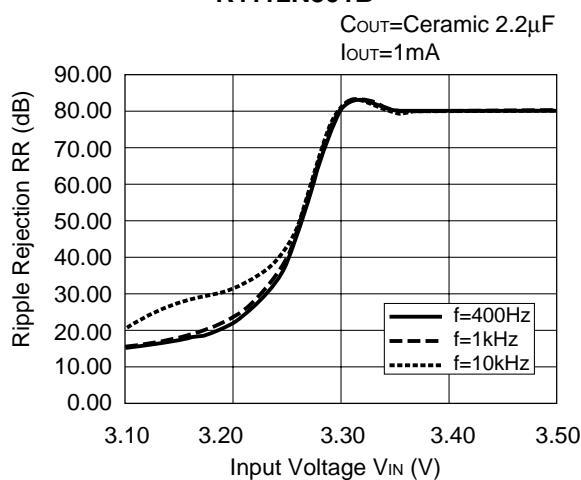
6) Supply Current vs. Temperature

R1112N151A/B**R1112N201A/B****R1112N301A/B****R1112N401A/B****R1112N501A/B**

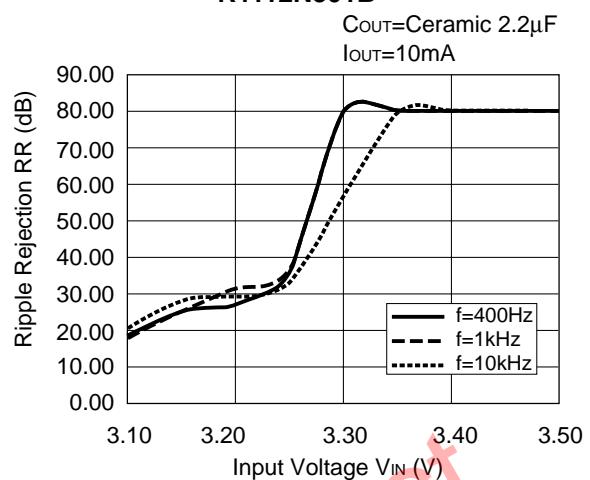
7) Ripple Rejection vs. Frequency**R1112N151A/B****R1112N201A/B****R1112N301A/B****R1112N401A/B****R1112N501A/B**

8) Ripple Rejection vs. Input Voltage (DC bias)

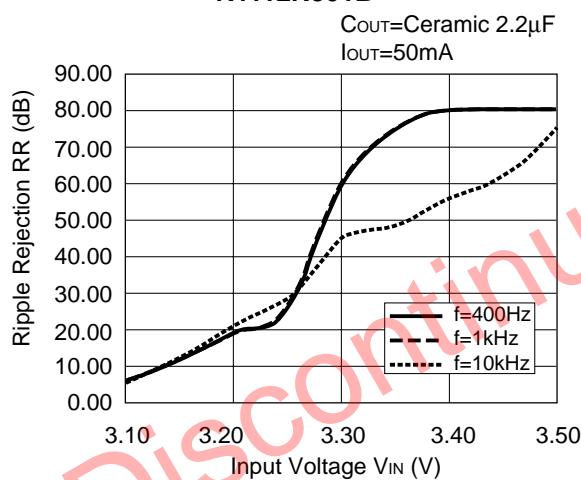
R1112N301B



R1112N301B

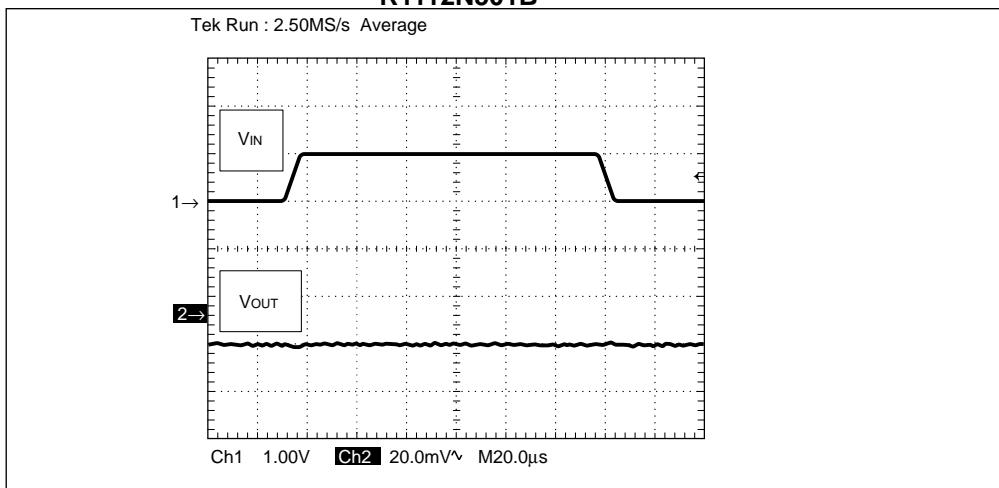


R1112N301B



9) Input Transient Response

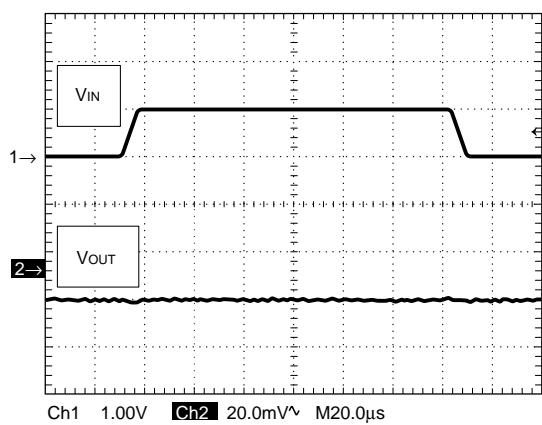
R1112N501B



R1112N

R1112N201B

Tek Run : 2.50MS/s Average

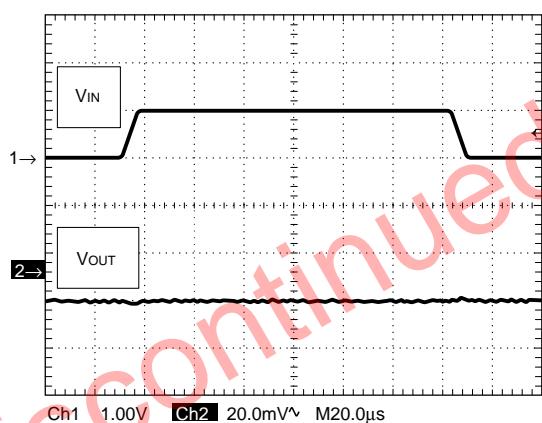


Topt=25°C

V_{IN}=3.0V↔4.0V
I_{OUT}=30mA
C_{IN}=none
C_{OUT}=2.2μF
tr/tf=5μs

R1112N301B

Tek Run : 2.50MS/s Average

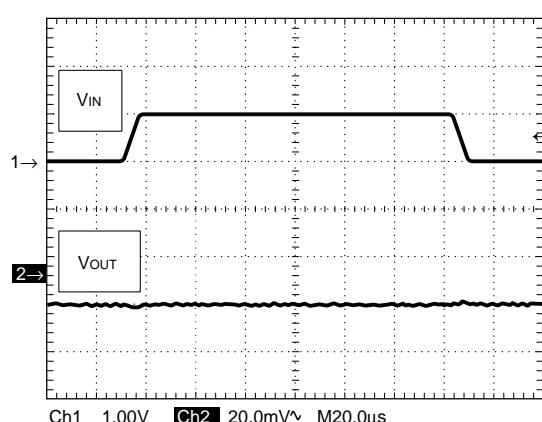


Topt=25°C

V_{IN}=4.0V↔5.0V
I_{OUT}=30mA
C_{IN}=none
C_{OUT}=2.2μF
tr/tf=5μs

R1112N401B

Tek Run : 2.50MS/s Average

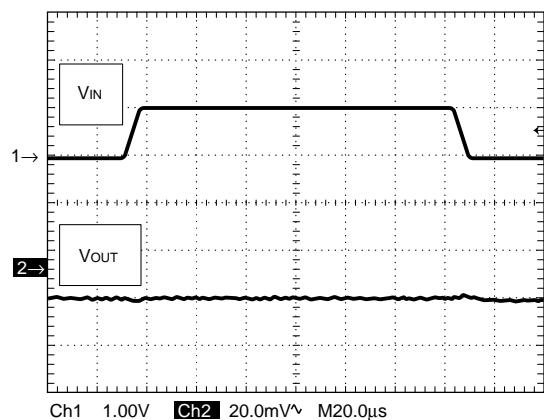


Topt=25°C

V_{IN}=5.0V↔6.0V
I_{OUT}=30mA
C_{IN}=none
C_{OUT}=2.2μF
tr/tf=5μs

R1112N501B

Tek Run : 2.50MS/s Average

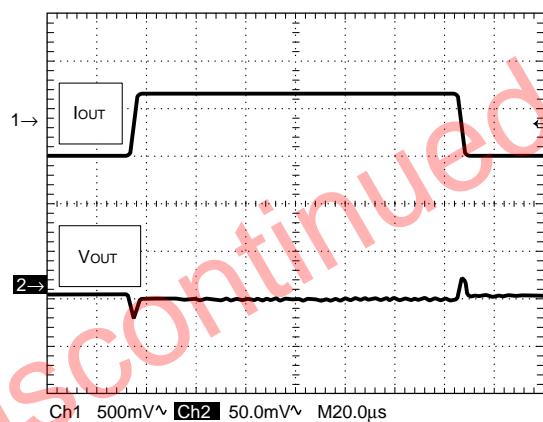


Topt=25°C

V_{IN}=6.0V↔7.0V
I_{OUT}=30mA
C_{IN}=none
C_{OUT}=2.2μF
tr/tf=5μs

10) Load Transient Response**R1112N151B**

Tek Run : 2.50MS/s Average

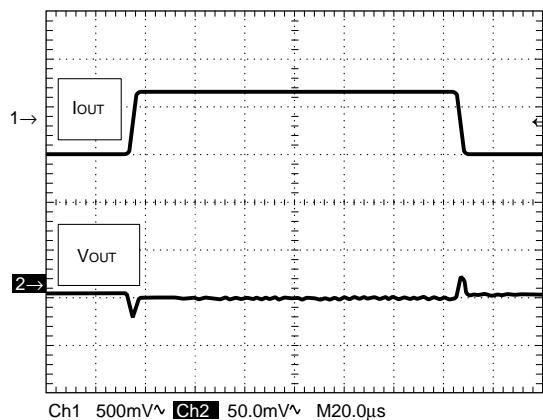


Topt=25°C

I_{OUT}=50mA↔100mA
V_{IN}=2.5V
C_{IN}=2.2μF
C_{OUT}=2.2μF
tr/tf=5μs

R1112N201B

Tek Run : 2.50MS/s Average



Topt=25°C

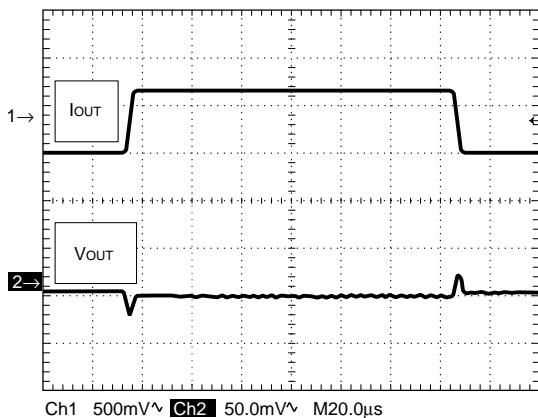
I_{OUT}=50mA↔100mA
V_{IN}=3.0V
C_{IN}=2.2μF
C_{OUT}=2.2μF
tr/tf=5μs

R1112N

R1112N301B

Topt=25°C

Tek Run : 2.50MS/s Average

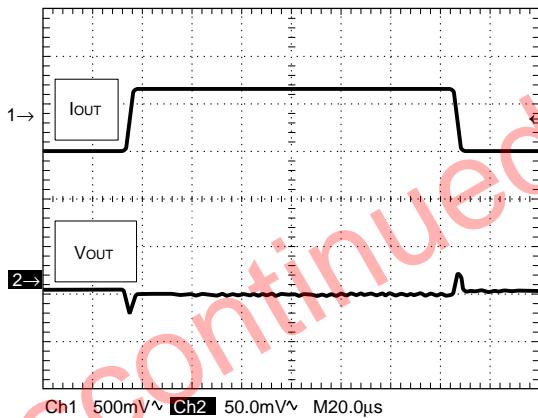


I_{OUT}=50mA↔100mA
V_{IN}=4.0V
C_{IN}=2.2μF
C_{OUT}=2.2μF
tr/tf=5μs

R1112N401B

Topt=25°C

Tek Run : 2.50MS/s Average

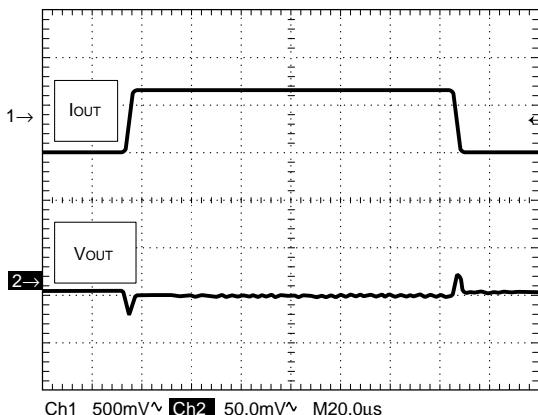


I_{OUT}=50mA↔100mA
V_{IN}=5.0V
C_{IN}=2.2μF
C_{OUT}=2.2μF
tr/tf=5μs

R1112N501B

Topt=25°C

Tek Run : 2.50MS/s Average

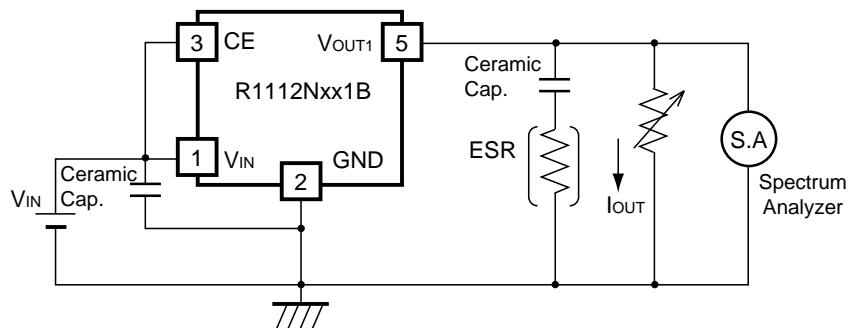


I_{OUT}=50mA↔100mA
V_{IN}=6.0V
C_{IN}=2.2μF
C_{OUT}=2.2μF
tr/tf=5μs

TECHNICAL NOTES

When using these ICs, consider the following points:

In these ICs, phase compensation is made for securing stable operation even if the load current is varied. For this purpose, be sure to use a capacitor C_{OUT} with good frequency characteristics and ESR (Equivalent Series Resistance) of which is in the range described as follows:



Measuring Circuit for white noise; R1112N301B

The relationship between I_{OUT} (the output current) and ESR of the output capacitor is shown in the graphs below. The conditions when the white noise level is under $40\mu V$ (Avg.) are indicated by the hatched area in the graph.

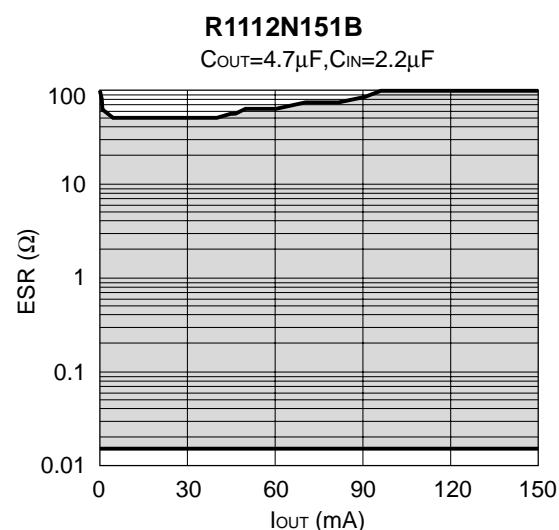
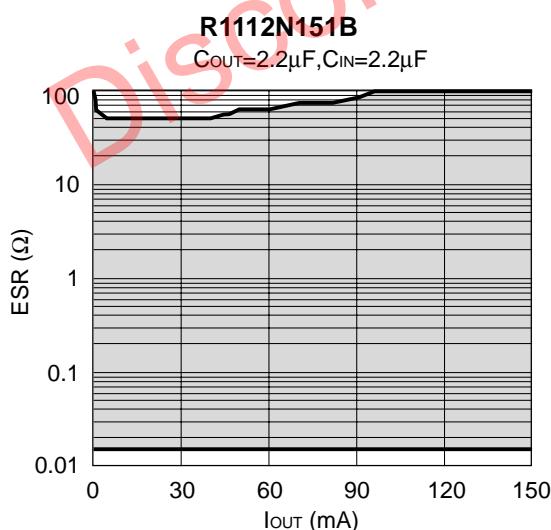
(Note: When additional ceramic capacitors are connected to the output pin with the output capacitor for phase compensation, operation might be unstable. Because of this, test these ICs with the same external components as the ones to be used on the PCB.)

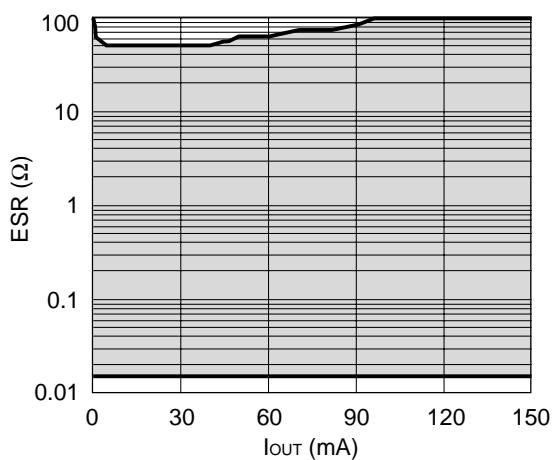
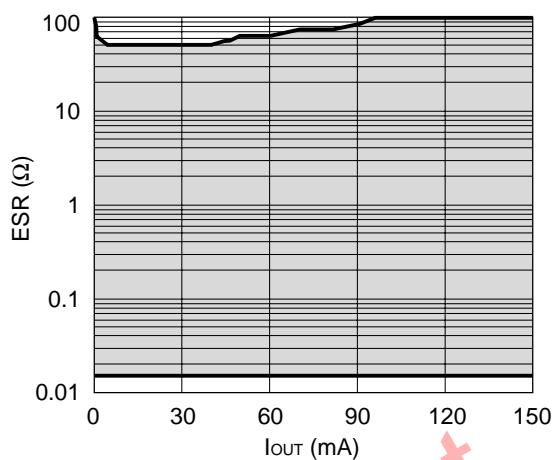
<Measuring Conditions>

(1) $V_{IN}=V_{OUT}+1V$

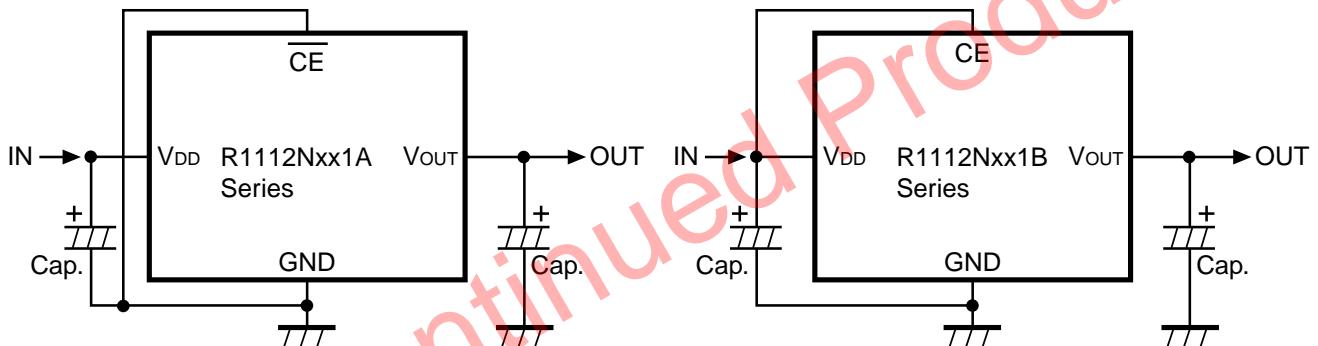
(2) Frequency band: 10Hz to 1MHz

(3) Temperature: $25^{\circ}C$



R1112N301B $C_{OUT}=2.2\mu F, C_{IN}=2.2\mu F$ **R1112N301B** $C_{OUT}=4.7\mu F, C_{IN}=2.2\mu F$ 

TYPICAL APPLICATION



(External Components)

Output Capacitor; Ceramic $2.2\mu F$ (Set Output Voltage in the range from 2.5 to 5.0V)Ceramic $4.7\mu F$ (Set Output Voltage in the range from 1.5 to 2.5V)Input Capacitor; Ceramic $2.2\mu F$



1. The products and the product specifications described in this document are subject to change or discontinuation of production without notice for reasons such as improvement. Therefore, before deciding to use the products, please refer to Ricoh sales representatives for the latest information thereon.
2. The materials in this document may not be copied or otherwise reproduced in whole or in part without prior written consent of Ricoh.
3. Please be sure to take any necessary formalities under relevant laws or regulations before exporting or otherwise taking out of your country the products or the technical information described herein.
4. The technical information described in this document shows typical characteristics of and example application circuits for the products. The release of such information is not to be construed as a warranty of or a grant of license under Ricoh's or any third party's intellectual property rights or any other rights.
5. The products listed in this document are intended and designed for use as general electronic components in standard applications (office equipment, telecommunication equipment, measuring instruments, consumer electronic products, amusement equipment etc.). Those customers intending to use a product in an application requiring extreme quality and reliability, for example, in a highly specific application where the failure or misoperation of the product could result in human injury or death (aircraft, spacevehicle, nuclear reactor control system, traffic control system, automotive and transportation equipment, combustion equipment, safety devices, life support system etc.) should first contact us.
6. We are making our continuous effort to improve the quality and reliability of our products, but semiconductor products are likely to fail with certain probability. In order to prevent any injury to persons or damages to property resulting from such failure, customers should be careful enough to incorporate safety measures in their design, such as redundancy feature, fire containment feature and fail-safe feature. We do not assume any liability or responsibility for any loss or damage arising from misuse or inappropriate use of the products.
7. Anti-radiation design is not implemented in the products described in this document.
8. The X-ray exposure can influence functions and characteristics of the products. Confirm the product functions and characteristics in the evaluation stage.
9. WLCSP products should be used in light shielded environments. The light exposure can influence functions and characteristics of the products under operation or storage.
10. There can be variation in the marking when different AOI (Automated Optical Inspection) equipment is used. In the case of recognizing the marking characteristic with AOI, please contact Ricoh sales or our distributor before attempting to use AOI.
11. Please contact Ricoh sales representatives should you have any questions or comments concerning the products or the technical information.



Ricoh is committed to reducing the environmental loading materials in electrical devices with a view to contributing to the protection of human health and the environment.

Ricoh has been providing RoHS compliant products since April 1, 2006 and Halogen-free products since April 1, 2012.

RICOH RICOH ELECTRONIC DEVICES CO., LTD.

<http://www.e-devices.ricoh.co.jp/en/>

Sales & Support Offices

RICOH ELECTRONIC DEVICES CO., LTD.
Higashi-Shinagawa Office (International Sales)
3-32-3, Higashi-Shinagawa, Shinagawa-ku, Tokyo 140-8655, Japan
Phone: +81-3-5479-2857 Fax: +81-3-5479-0502

RICOH EUROPE (NETHERLANDS) B.V.
Semiconductor Support Centre
Prof. W.H. Keesomlaan 1, 1183 DJ Amstelveen, The Netherlands
Phone: +31-20-5474-309

RICOH INTERNATIONAL B.V. - German Branch
Semiconductor Sales and Support Centre
Oberrather Strasse 6, 40472 Düsseldorf, Germany
Phone: +49-211-6546-0

RICOH ELECTRONIC DEVICES KOREA CO., LTD.
3F, Haesung Bldg, 504, Teheran-ro, Gangnam-gu, Seoul, 135-725, Korea
Phone: +82-2-2135-5700 Fax: +82-2-2051-5713

RICOH ELECTRONIC DEVICES SHANGHAI CO., LTD.
Room 403, No.2 Building, No.690 Bibo Road, Pu Dong New District, Shanghai 201203,
People's Republic of China
Phone: +86-21-5027-3200 Fax: +86-21-5027-3299

RICOH ELECTRONIC DEVICES CO., LTD.
Taipei office
Room 109, 10F-1, No.51, Hengyang Rd., Taipei City, Taiwan (R.O.C.)
Phone: +886-2-2313-1621/1622 Fax: +886-2-2313-1623